

HWK3: Lookup Table (LUT) vs. Regression on ESP32

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1 Introduction

In **HWK2** I obtained a regression function to approximate the relation between the ADC input and the calibrated output of a homemade moisture sensor. In **HWK3** the goal is to replace on-device polynomial evaluation with a *Lookup Table* (LUT) to reduce CPU cost at runtime. Concretely, the assignment requires: (i) generating the LUT in Python, (ii) exporting a C header with header guards, (iii) measuring execution time on the ESP32 for *regression vs. lookup*, and (iv) submitting the work via GitHub Pull Request.

2 Development

2.1 Final HWK2 model

My final HWK2 model was a **4th-order** polynomial mapping % water \rightarrow voltage:

$$V(x) = 4.60897e-09x^5 - 1.13065e-06x^4 + 9.13377e-05x^3 - 0.00277445x^2 + 0.0639597x + 0.154238, \quad (1)$$

where x is the water percentage in $[0, 100]$ and V is in volts.

2.2 Strategy: LUT indexed by millivolts (mV)

Because the regression is $V = f(\% \text{ water})$, the firmware flow uses the ESP-IDF ADC calibration to get **mV** from RAW and then uses a LUT to map **mV** \rightarrow %. This avoids evaluating or inverting the polynomial on the MCU and keeps timing deterministic.

2.3 Python (Google Colab): LUT generation and C header export

Below is the exact Colab code I used to generate a LUT that **inverts** $V = f(p)$ by *bisection* for each $mV \in [0, 3300]$, then exports `lookuptable.h` with header guards and macros (LUT size/scale/index mode). This satisfies the “generate header file with guards” requirement.

Listing 1: Colab: mV \rightarrow % LUT (bisection inversion) and C header export

```
1 !pip -q install numpy
2 import numpy as np
3 from google.colab import files
```

```

5
6
7 def voltage_from_percent(p):
8     x = p
9     coefficients here)
10
11     return (((((4.60897e-09*x - 1.13065e-06)*x + 9.13377e-05)*x
12               - 0.00277445)*x + 0.0639597)*x + 0.154238)
13
14 MV_FS = 3300
15 USE_UINT8 = True
16
17 def percent_from_mV(mv):
18     target = mv / 1000.0
19     v0 = voltage_from_percent(0.0)
20     v1 = voltage_from_percent(100.0)
21     if target <= v0: return 0.0
22     if target >= v1: return 100.0
23     lo, hi = 0.0, 100.0
24     for _ in range(40):
25         mid = 0.5*(lo+hi)
26         vm = voltage_from_percent(mid)
27         if vm < target: lo = mid
28         else: hi = mid
29     return 0.5*(lo+hi)
30
31 percent = np.array([percent_from_mV(mv) for mv in range(MV_FS+1)])
32 if USE_UINT8:
33     lut_vals = np rint(np.clip(percent, 0, 100)).astype(np.uint8) #
34     # 0..100
35     c_type = "uint8_t"; LUT_SCALE = 1
36 else:
37     lut_vals = np rint(np.clip(percent*10.0, 0, 1000)).astype(np.uint16)
38     # 0..1000
39     c_type = "uint16_t"; LUT_SCALE = 10
40
41 lines = []
42 lines.append("#ifndef LOOKUPTABLE_H")
43 lines.append("#define LOOKUPTABLE_H")
44 lines.append("")
45 lines.append("#include <stdint.h>")
46 lines.append(f"#define LUT_SIZE {MV_FS+1}")
47 lines.append(f"#define LUT_SCALE {LUT_SCALE} // 1:% integer; 10:"
48               f"tenths")
49 lines.append(f"#define LUT_INDEX_IS_MV 1 // index = mV (0..3300)")
50 lines.append("")
51 lines.append(f"static const {c_type} lookup_table[LUT_SIZE] = {{{")
52 row=[]
53 for i,v in enumerate(lut_vals):
54     row.append(str(int(v)))
55     if (i+1)%16==0:
56         lines.append(" " + ", ".join(row) + ","); row=[]
57 if row:
58     lines.append(" " + ", ".join(row) + ",")
59 lines.append("}");
60 lines.append("")
61 lines.append("#endif // LOOKUPTABLE_H")

```

```

60 with open("lookuptable.h", "w") as f:
61     f.write("\n".join(lines))
62 files.download("lookuptable.h")
63 print("Generated lookuptable.h (mV -> %)    ")

```

2.4 ESP-IDF integration: using the LUT in firmware

This is the exact ESP-IDF `oneshot_read_main.c` I used, which (1) reads/calibrates the ADC, (2) computes % via the **LUT**, and (3) measures execution time for both **polynomial inversion** and **lookup** using `esp_timer_get_time()`. This follows the assignment's timing requirement.

Listing 2: ESP-IDF firmware: LUT + timing vs. polynomial inversion

```

1  #include <stdio.h>
2  #include "freertos/FreeRTOS.h"
3  #include "freertos/task.h"
4  #include "esp_log.h"
5  #include "esp_timer.h"
6  #include "esp_adc/adc_oneshot.h"
7  #include "esp_adc/adc_cali.h"
8  #include "esp_adc/adc_cali_scheme.h"
9
10 #include "lookuptable.h"    LUT_INDEX_IS_MV
11
12 #define MY_ADC_UNIT        ADC_UNIT_1
13 #define MY_ADC_CHANNEL      ADC_CHANNEL_5
14 #define MY_ADC_ATTEN        ADC_ATTEN_DB_12
15 #define MY_ADC_BITWIDTH     ADC_BITWIDTH_DEFAULT
16
17 static bool adc_cali_init(adc_unit_t unit, adc_atten_t atten,
18     adc_cali_handle_t *out) {
19     *out = NULL;
20     #if ADC_CALI_SCHEME_CURVE_FITTING_SUPPORTED
21         adc_cali_curve_fitting_config_t cfg = { .unit_id=unit, .atten=atten,
22             .bitwidth=MY_ADC_BITWIDTH };
23         if (adc_cali_create_scheme_curve_fitting(&cfg, out) == ESP_OK)
24             return true;
25     #elif ADC_CALI_SCHEME_LINE_FITTING_SUPPORTED
26         adc_cali_line_fitting_config_t cfg = { .unit_id=unit, .atten=atten,
27             .bitwidth=MY_ADC_BITWIDTH };
28         if (adc_cali_create_scheme_line_fitting(&cfg, out) == ESP_OK) return
29             true;
30     #endif
31     return false;
32 }
33
34 static void adc_cali_deinit(adc_cali_handle_t h) {
35     #if ADC_CALI_SCHEME_CURVE_FITTING_SUPPORTED
36         if (h) adc_cali_delete_scheme_curve_fitting(h);
37     #elif ADC_CALI_SCHEME_LINE_FITTING_SUPPORTED
38         if (h) adc_cali_delete_scheme_line_fitting(h);
39     #endif
40 }
41
42 static inline double voltage_from_percent(double p) {
43     double x = p;
44     return (((((4.60897e-09*x - 1.13065e-06)*x + 9.13377e-05)*x

```

```

41         - 2.77445e-03)*x + 6.39597e-02)*x + 1.54238e-01);
42     }
43     static inline double percent_from_mV_poly(int mv) {
44         if (mv < 0) return 0.0;
45         double targetV = mv / 1000.0;
46         double lo = 0.0, hi = 100.0;
47         for (int i = 0; i < 40; ++i) {
48             double mid = 0.5*(lo + hi);
49             double Vm = voltage_from_percent(mid);
50             if (Vm < targetV) lo = mid; else hi = mid;
51         }
52         double p = 0.5*(lo + hi);
53         if (p < 0.0) p = 0.0; else if (p > 100.0) p = 100.0;
54         return p;
55     }
56
57     // LUT path (mV -> %):
58     static inline double percent_from_lut(int raw, int mv) {
59     #if defined(LUT_INDEX_IS_MV) && (LUT_INDEX_IS_MV == 1)
60         int idx = mv;
61     #else
62         int idx = raw;
63     #endif
64         if (idx < 0) idx = 0;
65         if (idx >= LUT_SIZE) idx = LUT_SIZE - 1;
66     #if (LUT_SCALE == 1)
67         return (double)lookup_table[idx];
68     #else
69         return lookup_table[idx] / 10.0;
70     #endif
71     }
72
73     void app_main(void) {
74         adc_oneshot_unit_handle_t adc;
75         adc_oneshot_unit_init_cfg_t ucfg = { .unit_id = MY_ADC_UNIT };
76         ESP_ERROR_CHECK(adc_oneshot_new_unit(&ucfg, &adc));
77
78         adc_oneshot_chan_cfg_t ccfg = { .bitwidth = MY_ADC_BITWIDTH, .atten
            = MY_ADC_ATTEN };
79         ESP_ERROR_CHECK(adc_oneshot_config_channel(adc, MY_ADC_CHANNEL, &
            ccfg));
80
81         adc_cali_handle_t cali = NULL;
82         bool do_cali = adc_cali_init(MY_ADC_UNIT, MY_ADC_ATTEN, &cali);
83
84         while (1) {
85             int raw = 0, mv = -1;
86             ESP_ERROR_CHECK(adc_oneshot_read(adc, MY_ADC_CHANNEL, &raw));
87     #if defined(LUT_INDEX_IS_MV) && (LUT_INDEX_IS_MV == 1)
88             if (do_cali) {
89                 if (adc_cali_raw_to_voltage(cali, raw, &mv) != ESP_OK) mv =
                    -1;
90             } else {
91                 mv = (int)((raw / 4095.0) * 3300.0 + 0.5);
92             }
93     #endif
94
95             int64_t t0 = esp_timer_get_time();

```

```

96     double pct_poly = percent_from_mV_poly(mv);
97     int64_t t1 = esp_timer_get_time();
98
99
100    int64_t t2 = esp_timer_get_time();
101    double pct_lut = percent_from_lut(raw, mv);
102    int64_t t3 = esp_timer_get_time();
103
104    printf("raw=%4d mv=%4d | poly=%.1f%% (%lld us) | LUT=%.1f%% (%
105           11d us)\n",
106           raw, mv, pct_poly, (long long)(t1 - t0), pct_lut, (long
107           long)(t3 - t2));
108
109    vTaskDelay(pdMS_TO_TICKS(200));
110 }
111
112 adc_cali_deinit(cali);
113 ESP_ERROR_CHECK(adc_oneshot_del_unit(adc));
114 }

```

2.5 CMake dependency (esp_timer)

Because we include `esp_timer.h` for timing, the main component must declare `esp_timer` as a private requirement:

Listing 3: main/CMakeLists.txt (dependencies)

```

1 idf_component_register(
2     SRCS "oneshot_read_main.c"
3     INCLUDE_DIRS "."
4     PRIV_REQUIRES esp_timer esp_adc
5 )

```

2.6 Submission

Per the brief, submit via GitHub on a branch `hwk3`, including the Colab script/notebook, the generated `lookuptable.h`, your ESP-IDF sources, and this report; then open a Pull Request. [:contentReference\[oaicite:4\]index=4](#)

3 Results

Console log screenshot (timing comparison)

Insert here the screenshot that compares the polynomial inversion time vs. the LUT time (recommended PNG/PDF).

Optional summary table

Table 1: Example summary of average timings over N runs.

Method	Avg. time [μ s]	Notes
Polynomial inversion	X	accurate; higher CPU
LUT (mV \rightarrow %)	Y	very fast; discretization

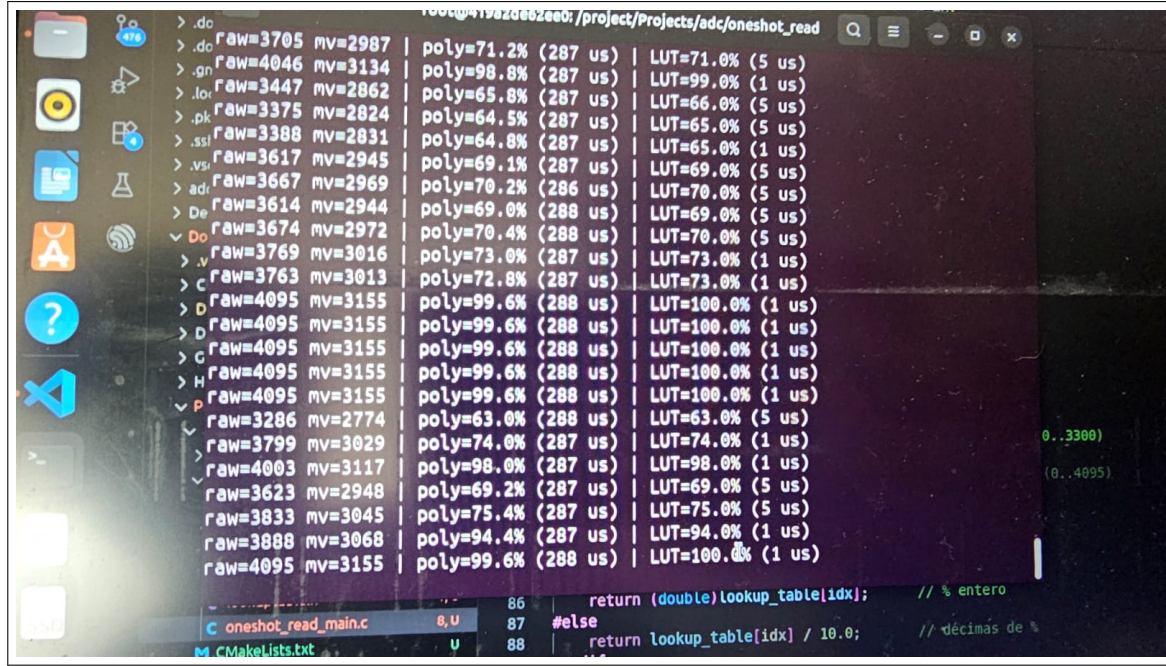


Figure 1: Timing comparison on ESP32: polynomial inversion vs. LUT (microseconds).

4 Conclusions

A **Lookup Table** trades a small amount of flash/RAM for very low, deterministic runtime cost: the mapping $V \rightarrow \%$ becomes a simple indexed read (optionally with linear interpolation), which is ideal in real-time loops. In this lab, where the regression (HWK2) is polynomial and the ADC runs continuously, the LUT significantly reduces latency and jitter while preserving fidelity within the operating range.

Advantages: (i) speed, (ii) determinism, (iii) simplicity in the measurement loop. **Disadvantages:** (i) memory footprint (a few KB), (ii) output discretization (tunable via resolution/scale), (iii) the table must be regenerated if the model or calibration changes. These trade-offs are well aligned with embedded constraints, and the measured results show the LUT path is substantially faster than computing or inverting the polynomial on-device.